

Search Notes

Application/Control No.

10/750,606

Examiner

Raymond Phan

Applicant(s)/Patent under
Reexamination

BOUCHIER ET AL.

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner
710	306-313	2/9/2006	RP
709	201-203	2/9/2006	RP
709	217-222	2/10/2006	RP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR